We are supporting global environment protection of an enterprise through quality improvement of thermophysical property measurement.





■ Specific	ations						
		TA35 Ultimate	TA33 Professional	TA32 Horizon	TA31 Vertical		
Basic function	Measurement object	Thermal diffusivity					
	Measurement range	$0.1\sim1000[\times10^{-6}\mathrm{m}^2\mathrm{s}^{-1}]$					
	Output data	Fre	Frequency, Distance, Amplitude, Phase, Thickness [TXT form]				
Measurement	In-plane	0	0	_	0		
mode	Out-of-plane	0	0	0	_		
	Distribution	0	_	_	_		
Accessories	Samp l e stage heater	Option	Option	_	_		
	Focus adjustment	Auto	Auto	Manual	Manual		
	Software	\circ	\circ	0	0		
	PC	0	0	0	0		
Measurement	Temperature	Room temp	Room temp	Room temp	Room temp		
environment	(Heater insta ll ed)	Room temp ∼ 300 [°C]	Room temp ∼ 300 [°C]	_	_		
	Frequency	0.01 [Hz]~100 [kHz]	0.01 [Hz]~100 [kHz]	0.01 [Hz]~100 [kHz]	0.01 [Hz]~100 [kHz]		
Laser diode	Wavelength	808 [nm]					
	Maximum output		1.5 [W]				
Radiation	Element		InSb				
thermometer	Cooling method	Liquid nitrogen					
Stage displacement	Detection stage	XY:±5 [mm]	XY:±5 [mm]	XY:±5 [mm]	_		
	Sample stage	XY:±10 [mm]	_	_	_		
Power supp l y			AC100-240[V], 10-5 [A], 50/60 [Hz]				
Usage environment	Temperature & Humidity	20~35 [°C], 20~80 [%]					
Repeatability		Less than $\pm5\%$					
Terms of use	Sample	Solid material(Resin•Glass•Ceramics•Metal•Diamond etc)					
	Shape	Any shape					
	Surface	Sample substrates should be flat and smooth for the best results (Thickness should be measurable).					
	Coating	Blacking processi	be unnecessary for graphite-based material).				
	Sample size (Max)	100 × 100 × 2 [mm]					
	Sample size (Min)	10 × 10 × 0.015 [mm]					
	Reference sample	Not necessary					
Main boby	Dimensions	W560×D740×H690 [mm]	W560×D740×H690 [mm]	W510×D720×H500 [mm]	W510×D720×H500 [mm]		

- The numbers shown in this catalog are results from our examinations. The same results are not guaranteed in different circumstances.
- The performance and appearance may be changed for improvement without notice.



Caution for Safety

Before using, please read manual and operate correctly for the safety.



Inquiry about products:

https://hrd-thermal.jp/en/contact/

<Manufactured and Distributed>

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Thermophysical Property Measurement System

Thermowave Analyzer

BETHEL THERMAL Search

Materialization of High Accurate, Precise and Contactless Thermal Diffusivity Measurement.











BETHEL Co., Ltd.

The first class model "TA35-Ultimate" that combines full functions from the measurement of the XYZ axis to the mapping measurement, High performance model "TA-33-Professional" that enables the anisotropy evaluation by the measurement of XYZ axis, Basic models "TA32-Horizon" and "TA31-Vertical" that

Please select favorite grade from four lineups according to the purpose of use at customers.

CONCEPT

High Performance and High Accurate Thermophysical Property Measurement System

Concept is "Thermal, Light, Safety, and Security".

Concentrating the BETHEL's know-how and technology for Thermophysical Property Measurement by deepening and fusing of the original products based on our original manufacturing prospect.

We wish to contribute to technological innovation and creating the future through our development of high accurate and precise thermophysical property measurement system.





2007









FEATURES

Features of Equipment

- Contactless thermal diffusivity measurement.
 - Adopt periodic heating and radiation thermometry method and contactless thermal diffusivity measurement with the laser.
- ◆ Wide range measurement. ~Organic films to Diamonds~
 - This device can measure wide range of samples from organic films to diamond with a single unit.
- ◆ Continuos measurement of in-plane& out-of-plane. ~Checking of anisotropy~ Continuous measurement can be performed in vertical (Z) and horizontal (XY) directions for same work and same sample.
- Mapping measurement is possible. ~Evaluate a defect and nonuniformity of samples~ It is possible to evaluate the distribution by the continuous measurement of thermal properties at plural points in out-of-plane.
- ◆ Measurement method of absolute values for easy condition setting. It is possible to get absolute values of thermal diffusivity.
 - And by "Easy Measurement" function, the setting of measurement condition is easily performed.
- ◆ A High degree of freedom of sample preparation can specify measurement point.
 - It is possible to choose closely measuring point and to measure the required points individually. And because being able to measure regardless of sample shape, the preparation of the sample is very easy which provides a capability to measure a sample with an irregular shape such as a circle and a triangle.
- ◆ Easy operation as being able to perform up to an analysis by PC, after placing samples on the stage.

After placing measurement sample on the test stand, it operates all of procedures up to the analysis by PC.

For user needs for the professional measurement that "desiring to evaluate difficult thermophysical property by own company".

Exerting great power to composite materials. Fully loaded with function and marvelous premium model.

It's best to evaluate the anisotropic materials. The high performance model with all necessary functions.

Analyze the anisotropy by continuous measurement of

three axis, standard model high performance function.



TA33

Professional

are limited to a necessary function.



















Function List

In-palne



by moving Z stage.



By heater installed , thermophysical property measurement in changing temperature from coom temperature at 300 $^{\circ}$ C can do.

For casual user, that "we have decided to limited function, and wish to use simply and easily."

The basic model with cheap edition which narrowed-down a necessary function at a pin point.

























Plural sample stage

Sample stage for pressure measurement

♦ etc...

Option

♦ Various test stage















SCENE

To a new stage by thermophsical property measurement

In development electronic device miniaturized evey year, solution of thermal problem is one of very important issues. It's essential to grasp exactly thermophysical property of parts and materials.

"Thermowave Analyzer TA35, 33, 32, 31" are widely used in verious scenes that grasp of thermophysical property need. For example, preformance confirmation of new matelials developments, thermal design at product development, quality control of manufacturing site, and inspection device of defect and nonuniformity of samples.

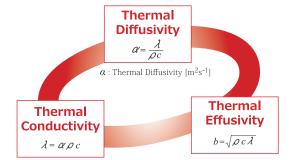
Utilization scene

are convertible to others

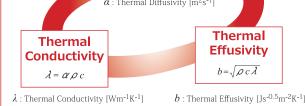
The thermal diffusivity can be converted to thermal

Thermophysical property values

conductivity and thermal effusivity by applying of specific heat and density.



 ρ : Density [kgm⁻³] c: Heat capacity [Jkg⁻¹K⁻¹]



■ Measurement Principle

THEORY

Measurement Principle

Irradiate the sample surface with a thermal diffusivity α with periodic heat source $P_{\alpha}e^{i\omega t}$. Alternate current component of temperature at the hot spot is expressed as $T_{ac} = T_{\theta} e^{i\omega t}$. The temperature diffusion induced around sample stage by periodic heat source $P_0e^{i\omega t}$, which is expressed by the following formula:

$$T_{ac} = \frac{P_0}{4\pi\alpha rc} \cdot e^{-kr + i(\omega t - kr)}$$

C is the heat capacity, r is distance from the heat so

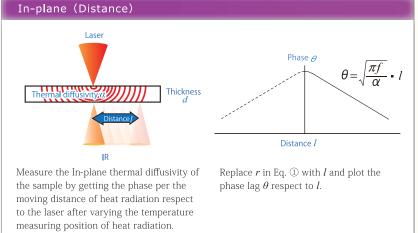
$$k = \sqrt{\frac{\omega}{2\alpha}} = \sqrt{\frac{\pi f}{\alpha}} = \frac{1}{\mu}$$

 μ is the thermal diffusion length. Therefore, the phase lag could be derived

$$\theta = -\sqrt{\frac{\pi f}{\alpha}} \cdot r$$

is possible

Schematic of Thermowave Analyzer



 $\theta = d\sqrt{\frac{\pi}{\alpha}} \sqrt{f}$ Frequency \sqrt{f} Measure the vertical thermal diffusivity of Replace r in Eq. 1 with d and plot the the sample by getting the phase per the phase lag θ respect to \sqrt{f} . frequency after varying the heating frequency of the laser.

The reason why BETHEL adheres to periodical heating radiation-temperature measuring method.

~ comparison with laser flash method ~

Periodical heating radiation-temperature measuring method		Laser flash method	
Periodical heating by beam	Heating method	Pulse heating by beam	
Small(ϕ 100~150 μ m)		Large(whole)	
Periodical heating at pinpoint	Laser diameter	Pulse heating at whole sample	
Z:Changing of phase for distance. XY:Changing of phase for distance.	Measuring axis and receving signal	Z:Curve of increase in temperature with time	
Measure a point aimed at pinpoint (Measuring area by one point: ϕ 500 μ m)	Range	Calculate the mean value of the physical property of whole samples.	
By continuously measuring of Z axis, evaluate nonuniformity of distribution.	Distribution evaluation	Impossible	
No restriction of external form of sample with φ 20mm or more	Shape	Depend on testing device	
Cu:300 μ m or more A thin sample can be measured.	Thickness	Cu:1000 μ m or more	
Not necessary	Sample cell	It's necessary to devise heat insulation methods as much as possible.	
 Therefore There is no restriction of sample shape Even a thin sample can be measured. Continuous measurement is performed in 3 axis XYZ directions for same work and same sample. Wide dynamic range Evaluation of distribution nonuniformity 	Total	Having a long history, it is most popular.Good at measurement of the homogeneous materials.	



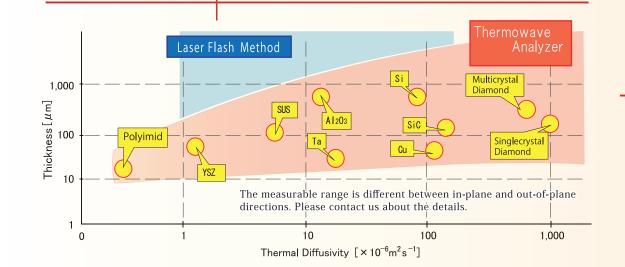
Thermowave Analyzer TA Series measures thermal diffusivity with

Periodical heating radiation-temperature measuring method.

Wide measurement range

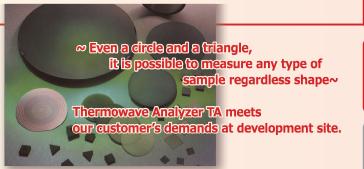
~Organic film to diamond~

Out-of-plane (Frequency)



FLEXIBLE SHAPES

It's possible to measure regardless of sample shape.



Since the adjustment of sample shape to testing device is not necessary, it is possible to attain significant reduction in a time-consuming job and cost.

SAFE & EASY OPERATION

Easy operation with only simply operating by PC after placing samples.





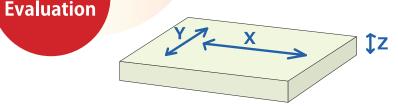
Next, it can be performed by PC operation up to data analysis.

APPLICATION





Continuous measurement for XYZ directions is possible ~ For evaluation of sample with anisotropy ~



- To evaluate heat radiation material of electronic parts
- To evaluate semiconductor laser of electrode
- To evaluate thermoelectric power generation
- To evaluate coating of carbide tool etc

Do you grasp the anisotropy of samples? For the composite materials of resin and various fillers (AlN, SiO₂, SiC, CNT), thermal diffusivity measurement is needed because the thermal conductivity changes significantly by the compounding ratio. Since this device can perform the continuous measurement for XYZ axis in the same work and same sample at a time, which is the

best device to measure the sample required to grasp the anisotropy. For example, the device is of great use to measure various samples such as heat dissipation sheet, carbon fiber reinforced resin, high thermal conductive resin and polyimide sheet used in electronics circuits, etc.

Mapping measurement

Visualizing of adhesion homogeneity of laminated lumber by the relative comparison of thermal conduction distribution.



■ CPU section



TIM heat spread

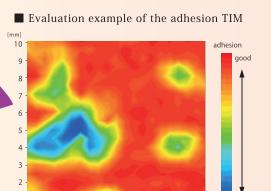
Because laminated materials are made by piling of materials with different thermal conduction, it is prefigured to change drastically heat transmission with homogeneity of adhesion. However, it was very difficult to perform the accurate measurement for thermal conductivity of laminated materials up to now and which has become one of pending issues in developing such materials. This device

Heat conduction changes drastically by the performance and adhesion of TIM

Visualizing the adhesion of TIM by distribution measurement

acquires continuously a phase delay of out-ofplane and further it is possible to evaluate relatively the thermal conduction of laminated materials by mapping data.

Not only performing the relative evaluation of thermal conductivity of materials, it is the most suitable for defect inspection or validation of homogeneity of parts.



1 2 3 4 5 6 7 8 9 10 [mm]

device, we made it measurable for

thermal conductivity by adjusting

ACCURACY High precision measurement

Anisotropy

The error between reference and measurement values is less (In the case of substance) than 2%

■ Measurment accuracy of the major metals

Sample Thickness [µm]			Thermal diffusi	vity $\alpha \ [\times 10^{-6} \text{m}^2 \text{ s}^{-1}]$	Difference to
		Orientation	TA measured	Reference value	reference value
CLICADA	100	In-plane	3.91	4.05	3.58 %
SUS304 100	Out-of-plane	3.92	4.03	3.32 %	
Ni	A.II. 200	In-plane	23.1	22.9	-0.87 %
Ni 300	Out-of-plane	22.5	22.9	1.78 %	
Mo		In-plane	54.1	54.3	0.37 %
Mo 300	Out-of-plane	54.3	34.3	0.00 %	
Cu 5	500	In-plane	120	117	-2.50 %
	300	Out-of-plane	117		0.00 %
Ag	g 500 C	In-plane	180	174	-3.33 %
		Out-of-plane	177		-1.69 %

■ The defference between measurment accuracy and reference value* when same point was repeatedly measured ten times.

Evaluation of

Temperature

Modulation

Time	Thermal diffusivity $\alpha \ [\times 10^{-6} \text{m}^2 \text{ s}^{-1}]$				
Time	Cu	Та			
1	115	25.2			
2	118	24.9			
3	114	25.1			
4	115	24.9			
5	116	25.0			
6	115	24.9			
7	115	25.1			
8	117	24.9			
9	116	25.1			
10	114	25.2			
Average value	115.5	25.0			
Standard deviation	1.27	0.13			
Repeatability	1.1%	0.5%			

	Thermal diffusivity α [×10 ⁻⁶ m ² s ⁻¹]		
	Cu	Та	
Measured	115.5	25.0	
Reference value	117	25.0	
Difference to reference value	-1.3 %	0.1 %	

- Orientation is vertical.
- Continuous measurement performed ten times under the same condition

It's possible to measure regardless of sample shape.

■Wire-shaped/Fibrous materials

0.5



Sample

Aluminum wire

Titanium wire

For the thermal property to be evaluated, the shapes of materials are various, and particularly, there are many needs to evaluate industrial material like wire, fibrous with shape as it is. For this samples.

Measured

94.9

precisely positions of the laser beam radiation and detection optical system observation to measuring

Thermal diffusivity [$\times 10^{-6}$ m² s⁻¹] Difference to reference value Reference value -1.9 % 96.8 4.8 %

We use 99.999% purity Aluminum and Titanium wire, producted by The Nilaco Corporation.

■Thin sheet materials



For the thermal conducting sheet, while keeping the high conductivity, flexibility and adhesion being able to adhere along the shape of heating element, which has an effect on

Measured by this device after preparing 2 samples with same materials and different thickness. The thermal conductivity was converted from thermal diffusivity by applying specific heat and density

reducing of the interfacial thermal contact resistance. Thermal property measurement is naturally necessary, but it was difficult to evaluate the anisotropy of thin sample up to now. save time for sample preparation, and enables users to perform the continuous measurement for XYZ 3

directions with the thickness as it is And it is able to evaluate not only the anisotropy but also the difference of thermal property value with the thickness. In the above table, it is In the case of this device, it is able to shown that a thinner material has higher thermal conductivity (diffusion) than thicker ones even the same

Sample	Thickness [mm]	Specific heat [Jg ⁻¹ K ⁻¹]	Density [gcm ⁻³]	Orientation	Thermal diffusivity [×10 ⁻⁶ m ² s ⁻¹]	Thermal conductivity [Wm ⁻¹ K ⁻¹]
	0.426	0.83	2.5	In-plane	0.71	1.4
Thermal conducting sheet				Out-of-plane	4.50	9.2
	0.213			In-plane	1.21	2.5
				Out-of-plane	5.22	10.6

■ Other special shapes

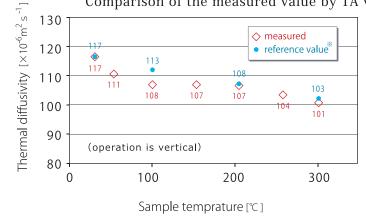


After CVD diamond and other materials created on a substrate, it's standing state. Even flaky material is measurable. Because "TA has a function to measure the temperature change at high speed" it is able to accommodate to such special measurement

* Reference values show literature and catalog values, or values measured with other methods.

■ For copper with temperature change. Comparison of the measured value by TA versus the reference value."

By a built-in heater, it's able to evaluate the change of thermophysical property by temperature. (option:heater)



Temperature	Thermal diffusi	Difference to		
remperature	TA measured	Reference value	reference value	
27°C (room)	117	117	0.0 %	
100℃	108	113	-4.4 %	
200℃	107	108	-0.9 %	
300℃	101	103	-1.9 %	

Since a pyrometry (RT~300°C) can be made, it is possible to evaluate thermal property at the same temperature as the actual usages. The measurement accuracy is not degraded even if

Wide variety of Measurement track record

- ♦ Sillicon heat dissipation sheet
- ♦ Graphite sheet
- ♦ High thermal conductive resin
- ♦ Multicrystal diamond
- ◇ Resin
- ♦ Ceramics
- ♦ Glass
- ♦ Metals
- ♦ Semiconductor materials
- ♦ etc...